## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination
10051093	LOLAYEKAR ET AL.
Examiner	Art Unit
Hanh Nguyen	2416

SEARCHED				
Class	Subclass	Date	Examiner	
370	389	3/11/09	HN	
	392			
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711	148			
	170	3/11/09	hn	

SEARCH NOTES			
Search Notes	Date	Examiner	
east serach(see serach history printout)	3/11/09	hn	

INTERFERENCE SEARCH				
Class	Subclass	Date	Examiner	
	Interference serach history printout	3/11/09	hn	

	/H. N./ Primary Examiner.Art Unit 2416
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